

IN THE CLAIMS

Please amend claims 1, 11, and 26.

Please enter the pending claims as follows:

1. (Currently Amended) A device having Input/Output (I/O) connections to a package or board comprising :
a bond pad[,];
vias disposed over said bond pad;
a BLM disposed over said ~~bond pad~~ vias, said BLM split into two or more segments, said segments in close proximity to each other, said segments separated by a gap[,]; and
a bump disposed over said segments.
2. (Previously Presented) The device of claim 1 wherein said bump comprises a Lead-Tin (Pb-Sn) solder.
3. (Previously Presented) The device of claim 1 wherein said bump is free of Lead (Pb).
4. (Previously Presented) The device of claim 1 wherein said bump comprises a Tin-Silver-Copper (Sn-Ag-Cu) ternary alloy.

5. (Previously Presented) The device of claim 1 wherein said bump comprises an Electrically Conductive Adhesive (ECA).
6. (Original) The device of claim 1 wherein said BLM provides a diffusion barrier to metals.
7. (Original) The device of claim 1 wherein said BLM comprises a lower layer and an upper layer.
8. (Original) The device of claim 7 wherein said lower layer comprises Titanium (Ti) with a thickness of about 200 to 1500 Angstroms.
9. (Original) The device of claim 7 wherein said upper layer comprises Nickel-Vanadium (Ni-V) with a thickness of about 1000 to 8000 Angstroms.
10. (Original) The device of claim 1 wherein said segments comprise a substantially polygonal layout.
11. (Currently Amended) The device of claim 1 ~~further comprising vias,~~ wherein each of said segments is electrically connected to two or more of said vias.

12. (Original) The device of claim 11, wherein said vias are laterally offset from a center of said bump to which they are electrically connected.
13. (Original) The device of claim 11 wherein said vias comprise a substantially polygonal layout.
14. (Previously Presented) The device of claim 1, further comprising another bond pad, wherein each of said segments is electrically connected to said bond pad and said another bond pad.
15. (Previously Presented) The device of claim 14 wherein said bond pad and said another bond pad are laterally offset from a center of said bump to which they are electrically connected.
- 16.-25. (Canceled)
26. (Currently Amended) A device having I/O connections to a package or board comprising :
 - a bond pad, said bond pad having two or more segments, and
 - a wire lead attached directly to said segments.
27. (Original) The device of claim 26 further comprising vias, wherein a segment is electrically connected to two or more of said vias.

28. (Original) The device of claim 26 further comprising lines, wherein a segment is electrically connected to two or more of said lines.